# Robust Kernel Hypothesis Testing under Data Corruption

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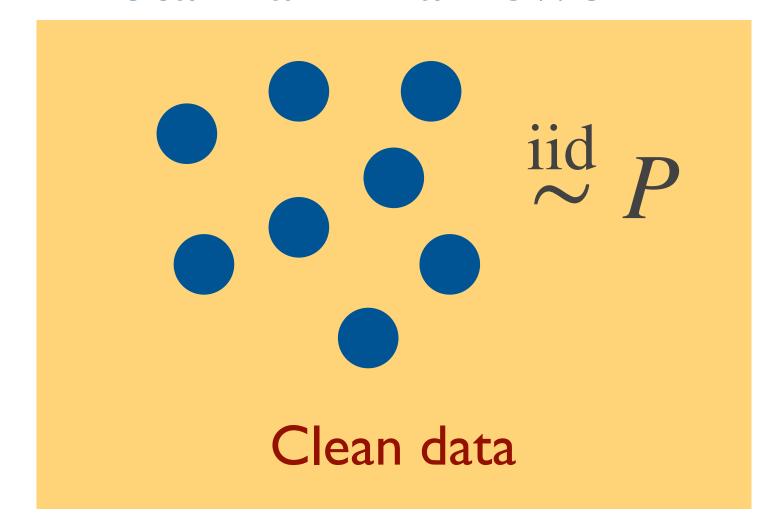
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## General Robust Testing Framework

- Space of distributions:  ${\mathscr P}$  partitioned into disjoint  ${\mathscr P}_0$  and  ${\mathscr P}_1$
- (Abstract) Goal: given data related to some fixed  $P \in \mathcal{P}$ , determine whether

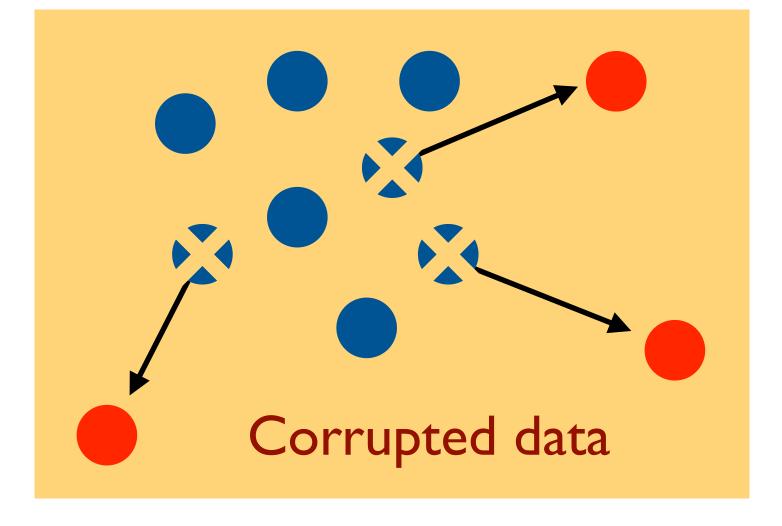
$$\mathcal{H}_0: P \in \mathcal{P}_0 \text{ or } \mathcal{H}_1: P \in \mathcal{P}_1$$

#### Standard framework



VS

#### Robust framework





## General Robust Testing Framework

- Space of distributions:  $\mathscr{P}$  partitioned into disjoint  $\mathscr{P}_0$  and  $\mathscr{P}_1$
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$$\mathcal{H}_0: P \in \mathcal{P}_0 \text{ or } \mathcal{H}_1: P \in \mathcal{P}_1$$

• (Specific) Goal: given  $X_1, ..., X_N$  related to some fixed  $P \in \mathcal{P}$ , determine whether

$$\mathcal{H}_0$$
:  $\tilde{X}_1,...,\tilde{X}_N$  are exchangeable or  $\mathcal{H}_1$ :  $\tilde{X}_1,...,\tilde{X}_N$  are not exchangeable

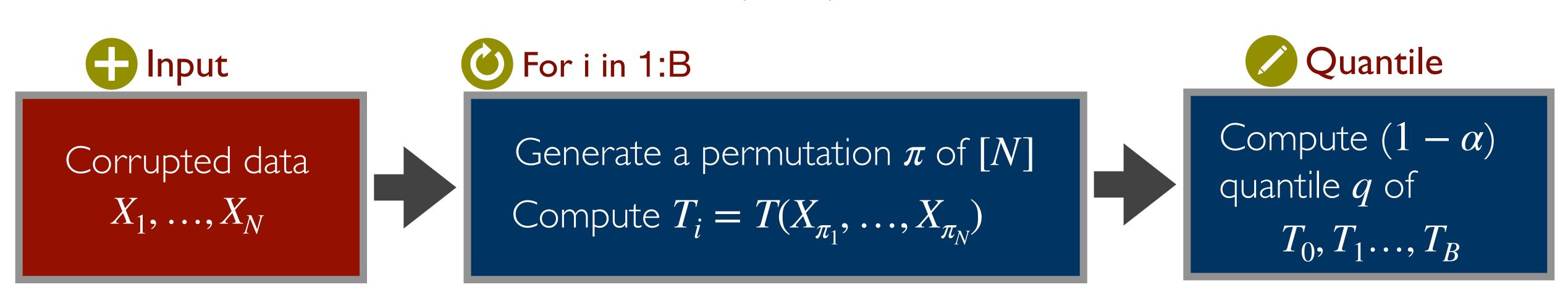
- Challenge: we don't observe  $X_1, \ldots, X_N$  but observe  $X_1, \ldots, X_N$  where
  - Up to r samples might have been corrupted arbitrarily
    N r samples are from P

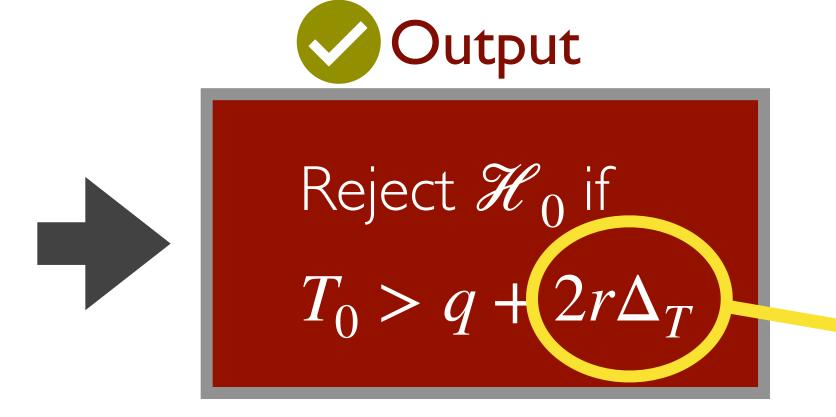


## DC Procedure for Robust Testing

ullet Global sensitivity: maximum possible change in T when one data point is arbitrarily changed

$$\Delta_T := \sup_{\boldsymbol{\pi} \in \mathbf{\Pi}_n} \sup_{\mathcal{X}_n, \mathcal{Y}_n : d_{\mathrm{ham}}(\mathcal{X}_n, \mathcal{Y}_n) \le 1} \left| T(\mathcal{X}_n^{\boldsymbol{\pi}}) - T(\mathcal{Y}_n^{\boldsymbol{\pi}}) \right|$$





We coin this as the "DC test":

A permutation test under data corruption

Adjustment factor for data corruption

#### DC Procedure for Robust Testing

#### We prove two fundamental results for the DC test

Level: the DC test is well-calibrated non-asymptotically

$$\mathbb{P}_{P_0}(\mathsf{DC} \ \mathsf{rejects} \ \mathscr{H}_0 \mid r \ \mathsf{corrupted} \ \mathsf{data}) \leq a$$

 $\mathbb{P}_{P_0} \big( \mathsf{DC} \ \mathsf{rejects} \ \mathscr{H}_0 \ | \ r \ \mathsf{corrupted} \ \mathsf{data} \big) \ \leq \ \alpha \quad \begin{cases} \mathsf{for} \ \mathsf{any} \ \mathsf{distribution} \ P_0 \in \mathscr{P}_0 \\ \mathsf{for} \ \mathsf{any} \ \mathsf{value} \ \alpha \in (0,1) \\ \mathsf{for} \ \mathsf{any} \ N \geq 1 \end{cases}$ 

Consistency: the DC test is consistent in the sense that

 $\lim_{N\to\infty}\mathbb{P}_{P_1}\big(\mathrm{DC\ rejects}\ \mathscr{H}_0\ |\ r\ \mathrm{corrupted\ data}\big)=1\ \mathrm{for\ any\ fixed\ distribution}\ P_1\in\mathscr{P}_1$ 

whenever 
$$\lim_{N\to\infty} \mathbb{P}_{P_1} \left( T(\mathbb{X}_n) > T(\mathbb{X}_n^{\pi}) + 4r\Delta_T \right) = 1$$

# I. Two-Sample Testing

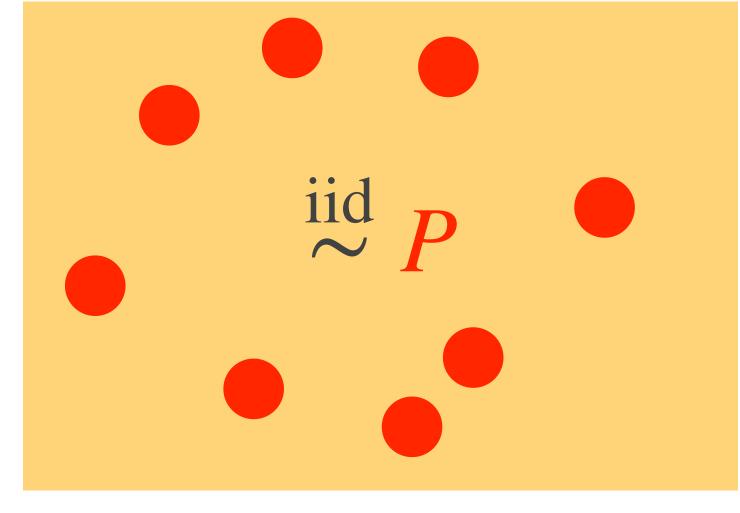
## 2. Independence Testing

## Robust Two-Sample Testing

- Two-sample problem: Given mutually independent
  - i.i.d. samples  $\tilde{X}_1, \dots, \tilde{X}_m$  from a distribution P
  - i.i.d. samples  $\tilde{Y}_1, \dots, \tilde{Y}_n$  from a distribution Q

test whether  $\mathcal{H}_0$ : P = Q or  $\mathcal{H}_1$ :  $P \neq Q$ 

• Robust testing: Up to r samples from either P or Q can be corrupted



i.i.d. Samples from P



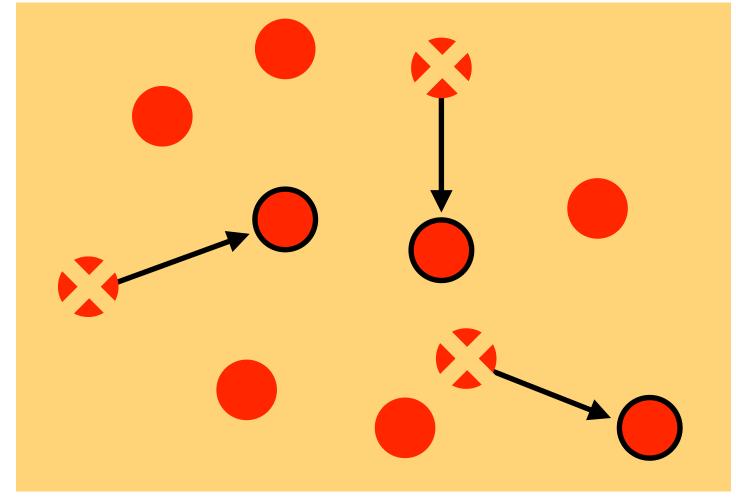
i.i.d. Samples from *Q* 

#### Robust Two-Sample Testing

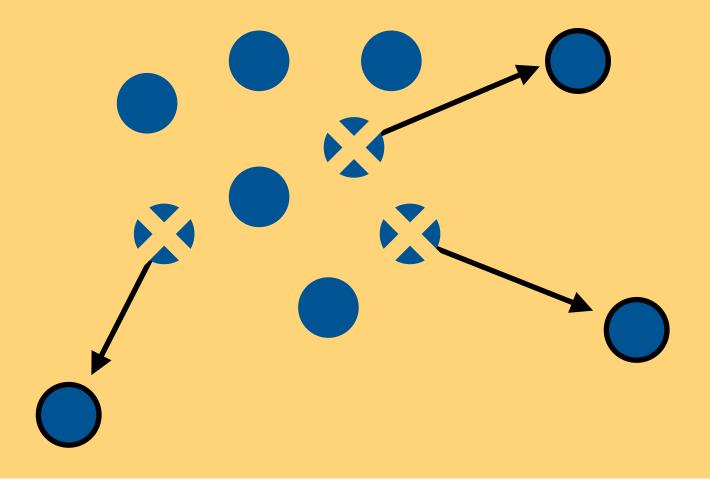
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Corrupted Samples from P



Corrupted Samples from Q

#### dcMMD Procedure

Maximum Mean Discrepancy:

$$MMD = \sqrt{\mathbb{E}_{P,P}[k(\boldsymbol{X}, \boldsymbol{X}')] - 2\mathbb{E}_{P,Q}[k(\boldsymbol{X}, \boldsymbol{Y})] + \mathbb{E}_{Q,Q}[k(\boldsymbol{Y}, \boldsymbol{Y}')]}$$

• Statistic (plug-in estimator):

$$\widehat{\text{MMD}} = \sqrt{\frac{1}{m^2} \sum_{1 \le i, i' \le m} k(\mathbf{X}_i, \mathbf{X}_{i'}) - \frac{2}{mn} \sum_{i=1}^{m} \sum_{j=1}^{n} k(\mathbf{X}_i, \mathbf{Y}_j) + \frac{1}{n^2} \sum_{1 \le j, j' \le n} k(\mathbf{Y}_j, \mathbf{Y}_{j'})}$$

- Global sensitivity of  $\widehat{\text{MMD}}$ :  $\Delta_{\widehat{\text{MMD}}} = \sqrt{2K/N}$  where K: kernel bound and  $N = \min(m, n)$
- dcMMD test: Apply DC procedure with  $\widehat{MMD}$  and  $\Delta_{\widehat{MMD}}$

#### dcMMD Guarantees

ullet Level: for any distribution P and any sample size

$$\mathbb{P}_{P,P}(dcMMD \text{ rejects } \mathcal{H}_0 \mid r \text{ corrupted data}) \leq \alpha$$

• Pointwise Power / Consistency: for any fixed  $P \neq Q$  and  $r/N \rightarrow 0$ 

$$\lim_{m,n\to\infty} \mathbb{P}_{P,\mathcal{Q}} (\operatorname{dcMMD rejects} \mathscr{H}_0 \mid r \text{ corrupted data}) = 1$$

• Uniform Power: for any distributions P and Q separated as

$$MMD(P,Q) \gtrsim \max \left\{ \sqrt{\frac{\max\{\log(1/\alpha), \log(1/\beta)\}}{\min(m,n)}}, \frac{r}{\min(m,n)} \right\}$$

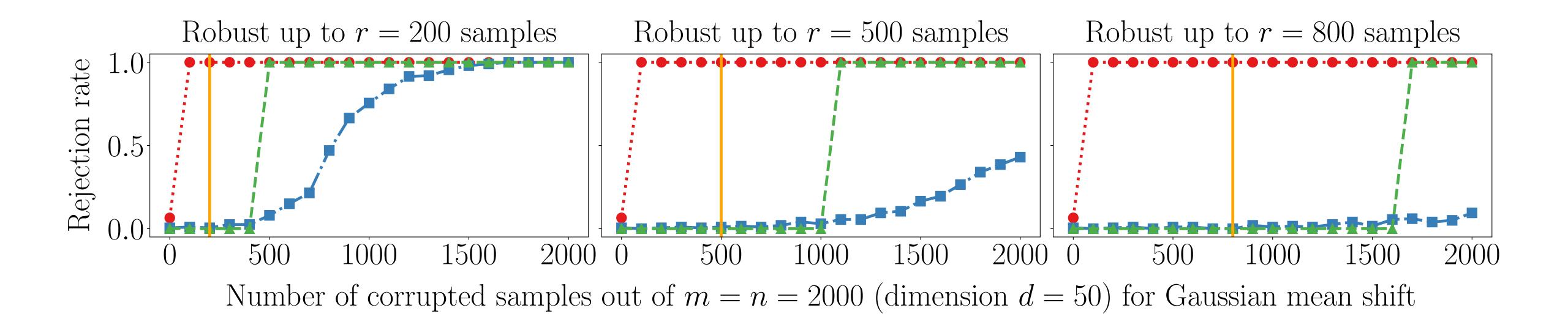
dcMMD achieves high power

$$\mathbb{P}_{P,Q}(dcMMD \text{ rejects } \mathcal{H}_0 \mid r \text{ corrupted data}) \geq 1 - \beta$$

This rate is minimax optimal with respect to  $m, n, r, \alpha, \beta$ .

## Experiments

#### dcMMD Experiments: Gaussian Mean Shift

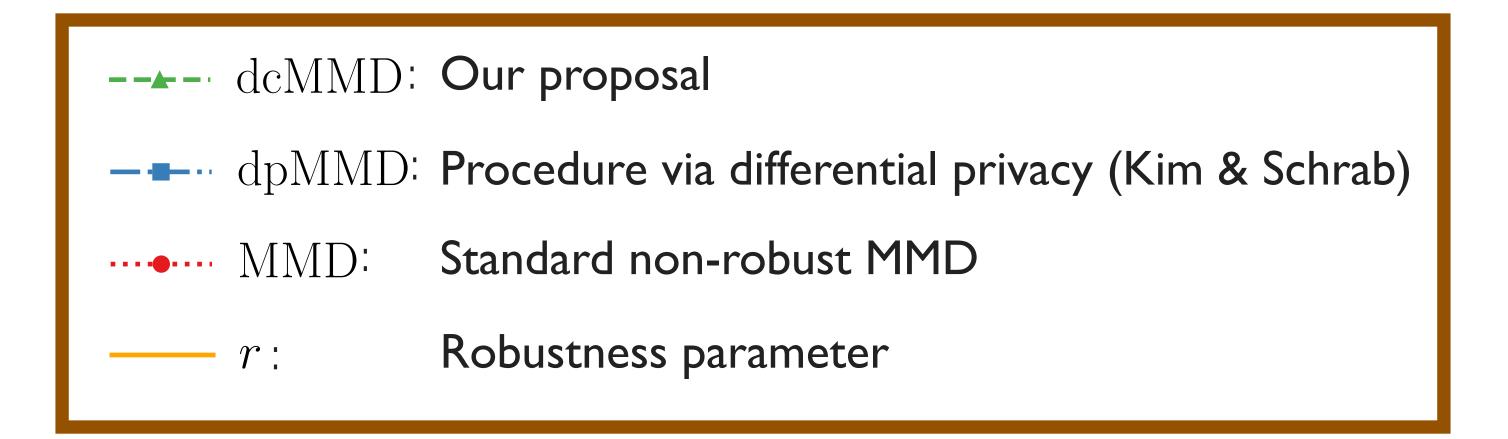


• Generate two samples

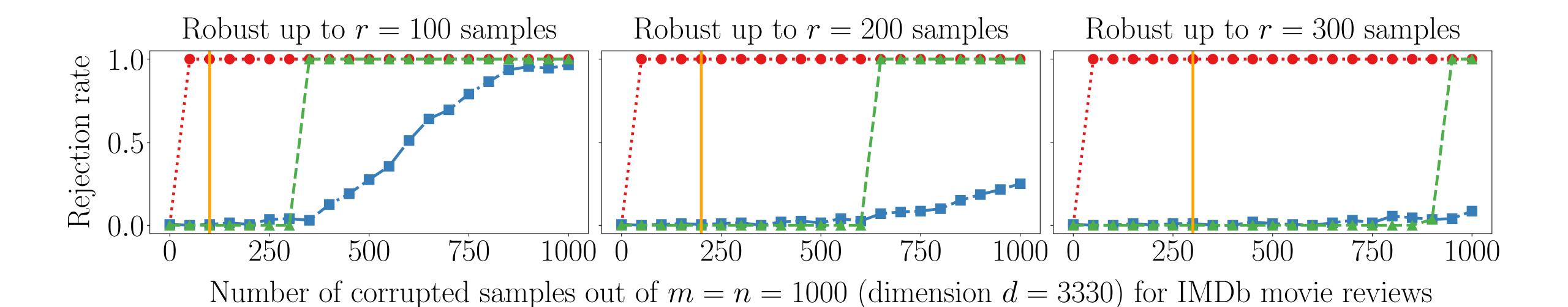
$$\tilde{X}_1, \dots, \tilde{X}_m \stackrel{\text{iid}}{\sim} N_d(0, 0.1)$$

$$\tilde{Y}_1, \dots, \tilde{Y}_n \stackrel{\text{iid}}{\sim} N_d(0, 0.1)$$

• Corrupt one sample using  $Z_1, ..., Z_k \stackrel{\text{iid}}{\sim} N_d(1000, 0.1)$ 



#### dcMMD Experiments: IMDb movie reviews



Generate two samples

$$\tilde{X}_1, ..., \tilde{X}_m \stackrel{\text{iid}}{\sim} \text{IMDb}(3330)$$

$$\tilde{Y}_1, ..., \tilde{Y}_n \stackrel{\text{iid}}{\sim} \text{IMDb}(3330)$$

• Corrupt one sample using  $Z_1, ..., Z_k \stackrel{\text{iid}}{\sim} \text{Geometric}(3330)$ 

dcMMD: Our proposal
 dpMMD: Procedure via differential privacy (Kim & Schrab)
 MMD: Standard non-robust MMD
 r: Robustness parameter

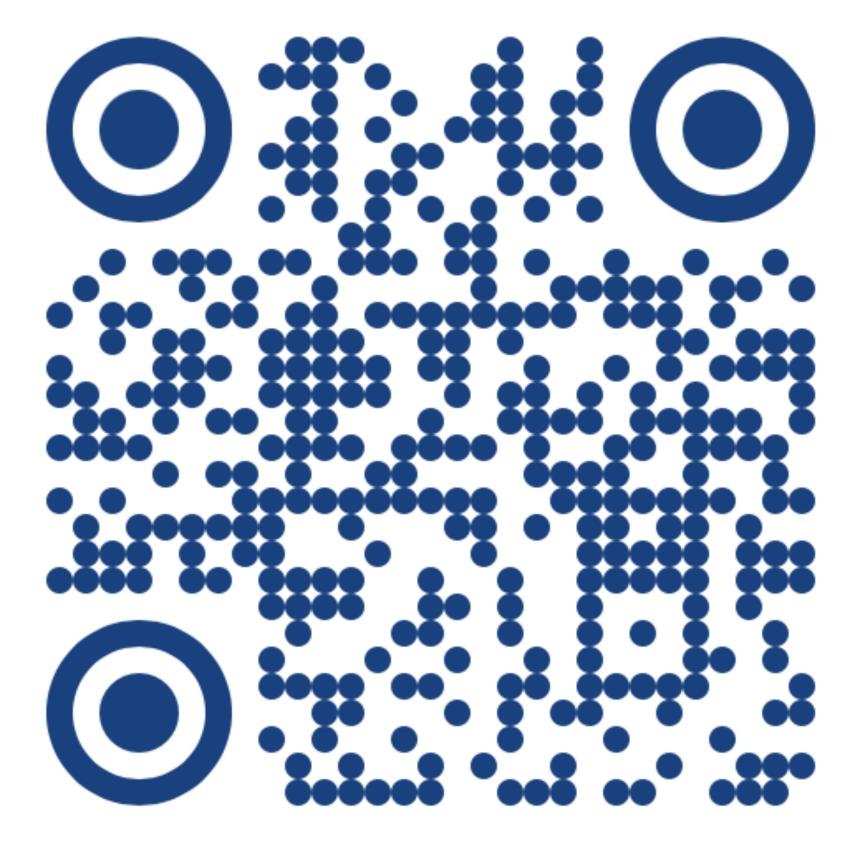
# Summary

#### Summary

- DC procedure: a general approach for constructing robust tests under data corruption
- Non-asymptotic validity and consistency under r data corruption
- Construct dcMMD and dcHSIC for two-sample and independence robust testing
- Prove that dcMMD/dcHSIC are minimax rate optimal
- Provide public implementations and illustrate the practicality

# Any Question?

#### Paper:



#### Code:

